




Issue Classification 	Application N .	Applicant(s)	
	10/049,820	BACH ET AL.	
	Examiner	Art Unit	
	Jinhee J Lee	2831	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
174		68.2		439	207	884	885	638	66
INTERNATIONAL CLASSIFICATION									
h	0	2	g						
				5/00					
				/					
				/					
				/					
				/					
Jinhee Lee (Assistant Examiner) (Date)				 DEAN A. REICHARD SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Date)				Total Claims Allowed: 18	
 Dongan Wang (Legal Instruments Examiner) (Date)								O.G. Print Claim(s) 21	O.G. Print Fig 4,5

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original		
1	1		31		61		91		121		151		181		
2	2		32		62		92		122		152		182		
3	3		33		63		93		123		153		183		
	4		34		64		94		124		154		184		
	5		35		65		95		125		155		185		
5	6		36		66		96		126		156		186		
6	7		37		67		97		127		157		187		
7	8		38		68		98		128		158		188		
13	9		39		69		99		129		159		189		
10	10		40		70		100		130		160		190		
11	11		41		71		101		131		161		191		
12	12		42		72		102		132		162		192		
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15	15		45		75		105		135		165		195		
4	16		46		76		106		136		166		196		
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9	18		48		78		108		138		168		198		
16	19		49		79		109		139		169		199		
17	20		50		80		110		140		170		200		
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	23		53		83		113		143		173		203		
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	27		57		87		117		147		177		207		
	28		58		88		118		148		178		208		
	29		59		89		119		149		179		209		
	30		60		90		120		150		180		210		